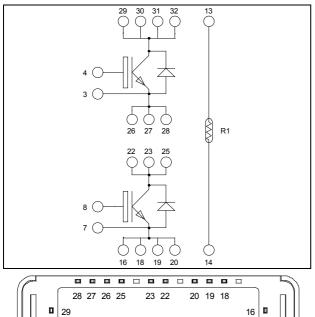


Phase leg Trench + Field Stop IGBT3 Power Module



#### 16 30 15 **D** 31 ۵ 14 13 🗖 32 10 11 12 2 3 4 8

Pins 29/30/31/32 must be shorted together Pins 26/27/28/22/23/25 must be shorted together to achieve a phase leg Pins 16/18/19/20 must be shorted together

### Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
V <sub>CES</sub>	Collector - Emitter Breakdown Voltage		1200	V
т	Continuous Collector Current	$T_C = 25^{\circ}C$	140	
I <sub>C</sub>	Continuous Conector Current	$T_{C} = 100^{\circ}C$	100	Α
I <sub>CM</sub>	Pulsed Collector Current	$T_C = 25^{\circ}C$	200	
V <sub>GE</sub>	Gate – Emitter Voltage		±20	V
PD	Maximum Power Dissipation	$T_C = 25^{\circ}C$	595	W
RBSOA	Reverse Bias Safe Operating Area	$T_j = 125^{\circ}C$	200A @ 1100V	

# APTGT100A120T3AG

### $V_{CES} = 1200V$ $I_{C} = 100A$ (a) $Tc = 100^{\circ}C$

### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### Features

- Trench + Field Stop IGBT3 Technology
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 20 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- Very low stray inductance
- Kelvin emitter for easy drive
- Internal thermistor for temperature monitoring
- High level of integration
- AlN substrate for improved thermal performance

### Benefits

- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



### All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

Electri Symbol	cal Characteristics	Test Conditions	ľ	Min	Typ	Max	Unit
I <sub>CES</sub>	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} =$			-JF	250	μΑ
Varia	Collector Emitter Saturation Voltage		1.4	1.7	2.1	V	
V <sub>CE(sat)</sub>				2.0			
V <sub>GE(th)</sub>	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C =$	= 2 mA	5.0	5.8	6.5	V
I <sub>GES</sub>	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE}$	=0V			400	nA

### **Dynamic Characteristics**

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$		7200		
Coes	Output Capacitance	$V_{CE} = 25V$		400		pF
C <sub>res</sub>	Reverse Transfer Capacitance	f=1MHz		300		
Q <sub>G</sub>	Gate charge	$V_{GE} = \pm 15V$ ; $V_{CE} = 600V$ $I_{C} = 100A$		0.9		μC
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (25°C)		260		
Tr	Rise Time	$V_{GE} = \pm 15V$		30		ns
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 600V$ $I_{C} = 100A$		420		
$T_{\mathrm{f}}$	Fall Time	$R_G = 3.9\Omega$		70		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (125°C)	)	290		
T <sub>r</sub>	Rise Time	$V_{GE} = \pm 15V$		50		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 600V$ $I_{C} = 100A$		520		ns
$T_{\rm f}$	Fall Time	$R_G = 3.9\Omega$		90		
Eon	Turn on Energy	$V_{GE} = \pm 15V V_{Bus} = 600V $ T <sub>j</sub> = 125°C		10		mJ
E <sub>off</sub>	Turn off Energy	$\begin{bmatrix} I_{C} = 100A \\ R_{G} = 3.9\Omega \end{bmatrix} T_{j} = 125^{\circ}C$		10		1115
I <sub>sc</sub>	Short Circuit data	$V_{GE} \le 15V$ ; $V_{Bus} = 900V$ $t_p \le 10\mu s$ ; $T_j = 125^{\circ}C$		400		А

### Reverse diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit	
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage			1200			V	
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> =1200V	$T_i = 25^{\circ}C$ $T_i = 125^{\circ}C$			350 500	μΑ	
I <sub>F</sub>	DC Forward Current		$T_1 = 123 \text{ C}$ Tc = 100°C		100	300	А	
V <sub>F</sub>	Diode Forward Voltage	$I_{\rm F} = 100 {\rm A}$ $V_{\rm GE} = 0 {\rm V}$	$T_i = 25^{\circ}C$		1.6	2.1	l v	
V F	Didde Forward Voltage		$T_{i} = 125^{\circ}C$		1.6		v	
t <sub>rr</sub>	Reverse Recovery Time	$ I_F = 100A V_R = 600V di/dt = 2300A/\mu s $	$T_j = 25^{\circ}C$		170		ns	
٩ſſ			$T_{j} = 125^{\circ}C$		280		115	
Q <sub>rr</sub>	Reverse Recovery Charge		$T_j = 25^{\circ}C$		11		μC	
Qrr	Reverse Recovery Charge		$di/dt = 2300 A/\mu s$ $T_j$	$T_{i} = 125^{\circ}C$		20		μυ
Б	Reverse Recovery Energy		$T_j = 25^{\circ}C$		4.4		mJ	
Er	Reverse Recovery Energy		$T_{j} = 125^{\circ}C$		8.2		ШJ	



### Thermal and package characteristics

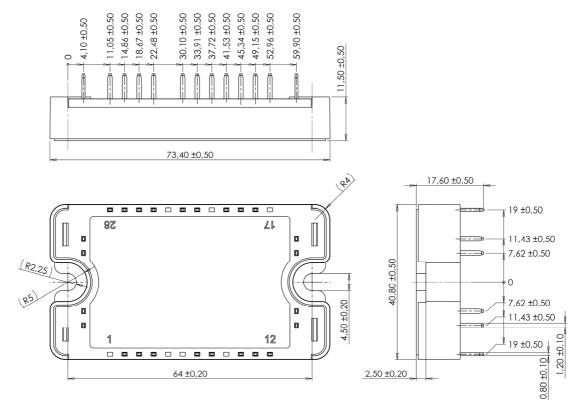
Symbol	Characteristic		Min	Тур	Max	Unit	
R <sub>thJC</sub>	Junction to Case Thermal Resistance IGBT Diode		IGBT			0.21	°C/W
<b>R</b> <sub>th</sub> JC			Diode			0.32	
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =1 min,		4000			V	
T <sub>J</sub>	Operating junction temperature range		-40		150		
T <sub>STG</sub>	Storage Temperature Range		-40		125	°C	
T <sub>C</sub>	Operating Case Temperature			-40		100	
Torque	Mounting torque	To heatsink	к M4	2		3	N.m
Wt	Package Weight				110	g	

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic			Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C	°C			50		kΩ
$\Delta R_{25}/R_{25}$					5		%
B <sub>25/85</sub>	T <sub>25</sub> =298.15 K				3952		K
$\Delta B/B$			$T_C = 100^{\circ}C$		4		%

$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature  
R<sub>T</sub>: Thermistor value at T

### SP3 Package outline (dimensions in mm)



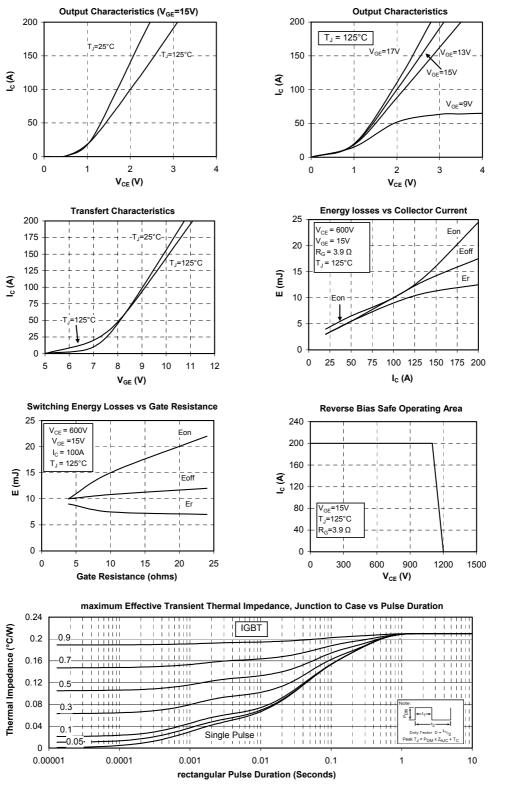
See application note 1901 - Mounting Instructions for SP3 Power Modules on www.microsemi.com

www.microsemi.com

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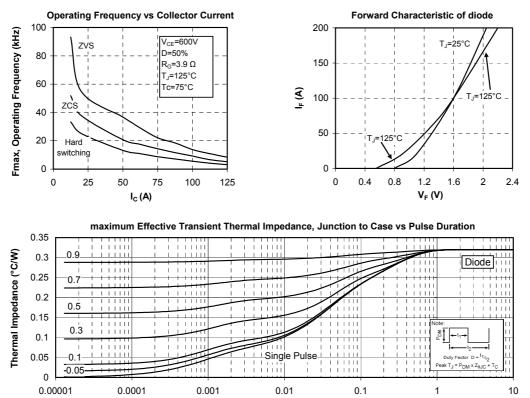
### **Typical Performance Curve**



APTGT100A120T3AG-Rev 1 October, 2012

www.microsemi.com





rectangular Pulse Duration (Seconds)

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